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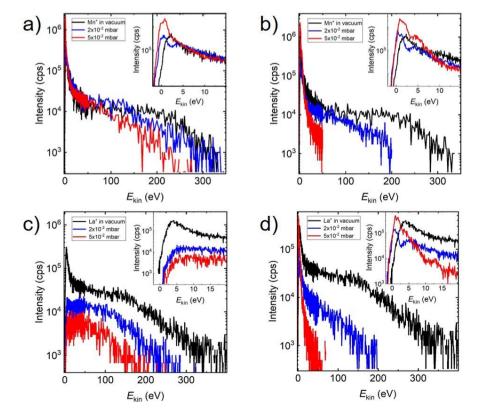
New Insight into the Gas Phase Reaction Dynamics in Pulsed Laser Deposition of Multi-Elemental Oxides

Pulsed laser deposition (PLD) has proved to be an outstanding technique for the deposition of complex oxide thin films due to its ability to congruently transfer the target composition to the deposited film. The deposition of many oxides is usually conducted using a pulsed KrF laser (λ = 248 nm corresponding to 4.99 eV/photon) with a pulse length of a few 10 ns in an O₂ background gas. The wavelength combined with the pulse length results in a plasma plume consisting largely of monoatomic plasma species (excited, ion, and neutral species plus electrons). The background gas moderates the kinetic energy of the expanding plume species, forming additional ions and excited state species. In addition, O₂ can act as a reactive background gas adjusting the oxidation of the ablated species and of the film. The gas-phase reaction dynamics and kinetics in a laser induced plasma are very much dependent on the interactions of the laser ablated target material and the background gas. As ions from the ablation process have a wide kinetic energy range, the question of interest is to determine the favourable kinetic energy window at which plasma species react/interact with the background gas molecules to form neutral and ionic metal-oxygen (MO) species. In this study, a detailed ion energy analysis of the kinetic energy distributions of the plasma species in the ablation process has been conducted using an energy-resolved mass spectrometer (Hiden EQP-MS). Figure 1 shows the ion energy distributions of monoatomic ions (Mn⁺ and La⁺) for the ablation of La_{0.33}Ca_{0.67}MnO₃ at different Ar and O₂ background pressures. The ion energy analysis by EQP-MS reveals that for the M⁺ ions with an MO⁺ dissociation energy smaller than that of O₂, here Mn⁺, the expansion in O₂ is similar to the expansion in Ar (Fig. 1a, b). While for ions with an MO⁺ dissociation energy larger than O₂ (La⁺, Fig. 1c) the expansion in O₂ differentiates itself from the expansion in Ar

(Fig. 1d) due to the formation of MO⁺.

Additionally, there is a favourable energy window where plasma species react with the background O₂ since a significant amount of MO⁺ species with low energies are detected with increasing pressure as a result of the f

Figure 1. The ion energy distributions for a) Mn^+ in \mathfrak{O}_2 , b) Mn^+ in Ar, c) La^+ in \mathfrak{O}_2 , d) La^+ in Ar, at three selected deposition pressures. The insets show the energy range between 0 and max. 20 eV for the ion energy distribution at different deposition pressures.





MO species. At a high oxygen background pressure, the preferred kinetic energy range to form MO species as a result of chemical reactions in an expanding plasma is up to 5 eV. We have further shown that the chemical activity of species for ablation in an oxygen background is reflected in the kinetic energy profile. Purely inelastic scattering is leading to a more discreet energy profile with several kinetic energy maxima as a result of excitations, ionization and dissociation processes (inset Fig. 1b, d) whereas added chemical activity results in a smooth kinetic energy distribution (inset Fig. 1a, c).

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Paper Reference:

"New Insight into the Gas Phase Reaction Dynamics in Pulsed Laser Deposition of Multi-Elemental Oxides" *Materials*. 2022; 15(14): 4862 DOI: 10.3390/ma15144862

Hiden Product:

EQP

Ref: AP-EQP-202147 Product: EQP Page 2